Modeling Of Dual Material Gate Junction less FinFET On Synopsis Sentaurus Tcad Tool

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Structure Editor (SDE) Script

```
(define M1 @M1@)
(sdegeo:create-cuboid (position 0 0 0) (position 0.028 0.03 0.010) "SiO2" "BOX")
(sdegeo:create-cuboid (position 0 0.013 0.010) (position 0.028 0.018 0.015) "Silicon"
"sourcedrain")
(sdegeo:set-default-boolean "BAB")
(sdegeo:create-cuboid (position (- M1 0.010) 0.010 0.010) (position M1 0.021 0.018) "HfO2"
"TOX")
(sdegeo:create-cuboid (position (- M1 0.010) 0 0.010) (position 0.014 0.03 0.022) "@Metal2@"
"M2")
(sdegeo:create-cuboid (position 0.014 0 0.010) (position M1 0.03 0.022) "@Metal1@" "M1")
(sdegeo:define-contact-set "source" 4 (color:rgb 1 0 0 ) "##")
(sdegeo:define-contact-set "drain" 4 (color:rgb 1 0 0 ) "##")
(sdegeo:define-contact-set "gate" 4 (color:rgb 1 0 0) "##")
(sdegeo:set-current-contact-set "source")
(sdegeo:set-contact (list (car (find-face-id (position 0.0235 0.0155 0.015)))) "source")
(sdegeo:set-current-contact-set "drain")
(sdegeo:set-contact (list (car (find-face-id (position 0.0045 0.0155 0.015)))) "drain")
(sdegeo:set-current-contact-set "gate")
(sdegeo:set-contact (list (car (find-face-id (position 0.0165 0.015 0.022)))) "gate")
(sdegeo:set-contact (list (car (find-face-id (position 0.0115 0.015 0.022)))) "gate")
```

```
(sdedr:define-constant-profile "ConstantProfileDefinition_1" "PhosphorusActiveConcentration" @Con@)
(sdedr:define-constant-profile-material "ConstantProfilePlacement_1"
"ConstantProfileDefinition_1" "Silicon")

(sdedr:define-refeval-window "RefEvalWin_1" "Cuboid" (position -0.005 -0.005 -0.005)
(position 0.031 0.031 0.031))
(sdedr:define-refinement-size "RefinementDefinition_1" 0.002 0.005 0.001 0.002 0.005 0.001)
(sdedr:define-refinement-placement "RefinementPlacement_1" "RefinementDefinition_1" (list "window" "RefEvalWin_1"))
(sdedr:define-refinement-function "RefinementDefinition_1" "DopingConcentration"
"MaxTransDiff" 1)
(sdedr:define-refinement-function "RefinementDefinition_1" "MaxLenInt" "SiO2" "Silicon" 1 1.25 "DoubleSide")

(sde:build-mesh "n@node@")
```

SDevice Script

```
File {
  * input files:
  Grid= "@tdr@"
  * output files:
  Plot = "@tdrdat@"
  Current ="@plot@"
  Output = "@log@"
  *Param = "Silicon.par"
}
Electrode {
   { Name = "source" Voltage=0}
   { Name = "drain" Voltage=0}
   { Name = "gate" Voltage=0 }
}
Physics (Material="Silicon"){
      Mobility( DopingDependence Enormal)
      Recombination (SRH(DopingDependence) Auger)
      EffectiveIntrinsicDensity(OldSlotboom)
      Recombination (
      Band2Band (
             Model = Schenk
```

```
DensityCorrection = Local
)
Physics (Material = "Aluminum") {
MetalWorkfunction (Workfunction= 4.28)
Physics (Material = "Titanium") {
MetalWorkfunction (Workfunction= 4.66)
}
Plot {
       eDensity hDensity eCurrent/Vector hCurrent/Vector
       ElectrostaticPotential Potential SpaceCharge ElectricField
       Doping DonorConcentration AcceptorConcentration
       TotalCurrentDensity
       ConductionBand ValenceBand
       TotalCurrentDensity/Vector eCurrentDensity/Vector hCurrentDensity/Vector
}
CurrentPlot {
eDensity(Integrate(Semiconductor))
}
Math {
  Extrapolate
```

```
Avalderivatives
  RelErrControl
  Digits=5
  ErRef(electron)=1.e10
  ErRef(hole)=1.e10
  Notdamped=50
  Iterations=20
  DirectCurrent
}
Solve {
NewCurrentPrefix="init"
 Coupled(Iterations=100) { Poisson }
 Coupled{ Poisson Electron Hole }
 Quasistationary(
  InitialStep=1e-1 Increment=1.2
  Minstep=1e-5 MaxStep=0.05
  Goal { Name="drain" Voltage= @Vd@ }
 ){ Coupled{ Poisson Electron Hole} }
 NewCurrentPrefix=""
 Quasistationary(
  DoZero
  InitialStep=0.02 Increment=1.5
  Minstep=0.02 MaxStep=0.02
```

```
Goal { Name="gate" Voltage= @Vg@ }
){ Coupled{ Poisson Electron Hole}
```

TCL script for parameter extraction

```
# Extract Vtgm for a p-MOSFET

set mydata [load_file "@plot@" -name DC]

set Vgs [get_variable_data "gate OuterVoltage" -dataset DC]

set Ids [get_variable_data "drain TotalCurrent" -dataset DC]

ext::AbsList -out absIds -x $Ids

ext::ExtractVtgm -out Vtgm -name "out" -v $Vgs -i $absIds

puts "Vt (Max gm method) is [format %.3f $Vtgm] V"

#-> Vt (Max gm method) is -0.234 V

ext::ExtractSS -out SS -name "out" -v $Vgs -i $Ids -vo $Vgo

puts "SS (subthreshold voltage swing) is [format %.3f $SS] mV/dec"

#-> SS (subthreshold voltage swing) is 89.555 mV/dec

ext::ExtractIoff -out Ioff -name "out" -v $Vgs -i $Ids -vo 1e-4 -log10 0

puts "Ioff is [format %.3e $Ioff] A/um"
```

TCL script for Id vs Vg curve

```
set mydata [load file "@plot@"]
set myplot [create plot -1d]
set IdVgcurve [create curve -plot $myplot -dataset $mydata \
              -axisX "gate InnerVoltage" -axisY "drain TotalCurrent"]
set curve prop $IdVgcurve -plot $myplot -show markers -markers size 7 \
  -markers type circlef -label "DMGJLFinFET"
set plot prop -show grid
set grid prop -show minor lines \
  -line1 style dash -line1 color #a0a0a4 \
  -line2 style dot -line2 color #c0c0c0
set axis prop -plot $myplot -axis x -title "V<sub>gate</sub> (V)"
set_axis_prop -plot $myplot -axis y -title "I<sub>drain/sub>/
(A/<greek>m</greek>m)" -type log
set axis prop -plot $myplot -axis y -range {1e-08 0.001}
export_view "n@node@_curve.png" -plots $myplot -resolution 500x500 \
  -format PNG -overwrite
```

```
(sdegeo:create-cuboid (position 0 0 0) (position 0.028 0.03 0.010) "si02" "BOX")
(sdegeo:create-cuboid (position 0 0.013 0.010) (position 0.028 0.018 0.015) "silicon" "sourcedrain")
(sdegeo:set-dealut-boolean "BAB")
(sdegeo:create-cuboid (position (- M1 0.010) 0.010 0.010) (position M1 0.021 0.018) "HF02" "TOX")

(sdegeo:create-cuboid (position (- M1 0.010) 0.010) (position M1 0.010 0.014 0.010)
(sdegeo:create-cuboid (position 0.014 0.010) (position M1 0.03 0.022) "@Metal20" "M2")
(sdegeo:define-contact-set "source" 4 (color:rgb 1 0 0) "##")
(sdegeo:define-contact-set "drain" 4 (color:rgb 1 0 0) "##")
(sdegeo:define-contact-set "drain")
(sdegeo:set-current-contact-set "drain")

(sdegeo:set-current-contact-set "drain")
(sdegeo:set-contact (list (car (find-face-id (position 0.015 0.015 0.015)))) "source")
(sdegeo:set-contact (list (car (find-face-id (position 0.0165 0.015 0.022)))) "gate")
(sdegeo:set-contact (list (car (find-face-id (position 0.0165 0.015 0.022)))) "gate")
(sdegeo:set-contact (list (car (find-face-id (position 0.0165 0.015 0.022)))) "gate")
(sdeder:define-constant-profile "ConstantProfileDefinition 1" "PhosphorusActiveConcentration" @Con@)
(sdedr:define-constant-profile "ConstantProfileDefinition 1" "PhosphorusActiveConcentration" @Con@)
(sdedr:define-refinement-placement 1" "ConstantProfileDefinition 1" "Silicon")

(sdedr:define-refinement-size "RefinementDefinition 1" "PhosphorusActiveConcentration" @Con@)
(sdedr:define-refinement-function "RefinementDefinition 1" "RefinementDefinition 1" "NaxIransDiff" 1)
(sdedr:define-refinement-function "RefinementDefinition 1" "ResinementDefinition " "NaxIransDiff" 1)
(sdedr:define-refinement-function "RefinementDefinition 1" "NaxIransDiff" 1)
(sdedr:define-refinement-function "RefinementDefinition 1" "NaxIransDiff" 1)
(sdedr:define-refinement-function "RefinementDefinition 1" "NaxIransDiff" 1)
```

Fig.2 Id Vs Vg TCL Script

```
set Vgo 1e-2

# Extract Vtgm for a p-MOSFET

set mydata [load file "@plot@" -name DC]

set Vgs [get_variable_data "gate OuterVoltage" -dataset DC]

set Ids [get_variable_data "drain TotalCurrent" -dataset DC]

ext::AbsList -out absIds -x $Ids

ext::ExtractVtgm -out Vtgm -name "out" -v $Vgs -i $absIds

puts "Vt (Max gm method) is [format %.3f $Vtgm] V"

#-> Vt (Max gm method) is -0.234 V

ext::ExtractS5 -out S5 -name "out" -v $Vgs -i $Ids -vo $Vgo

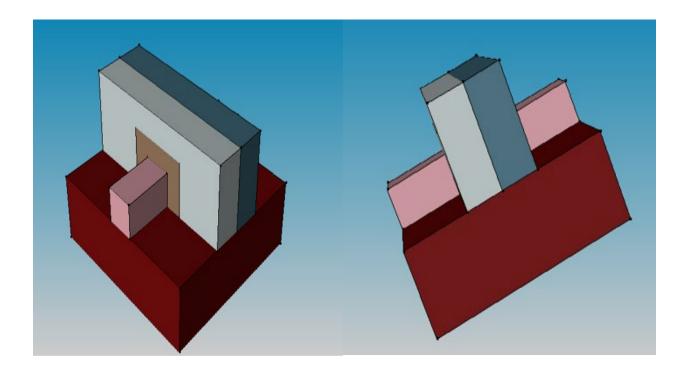
puts "S5 (subthreshold voltage swing) is 8j.555 mv/dec"

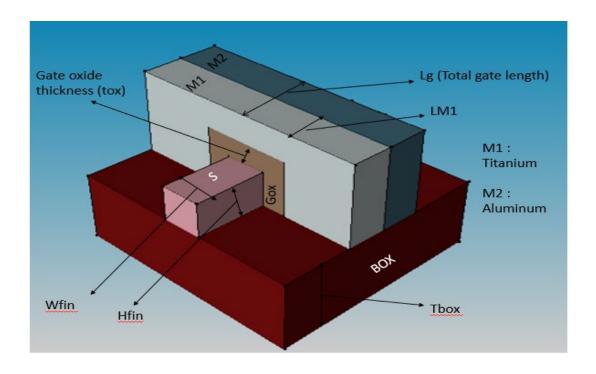
#-> S5 (subthreshold voltage swing) is 8g.555 mv/dec

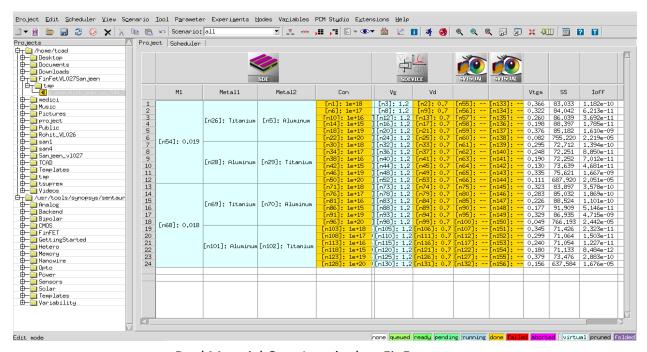
ext::ExtractIoff -out Ioff -name "out" -v $Vgs -i $Ids -vo le-4 -log10 0

puts "Ioff is [format %.3e $Ioff] A/um"
```

Fig.3 Parameter TCL Script



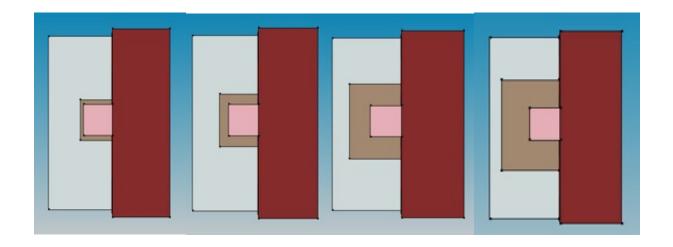




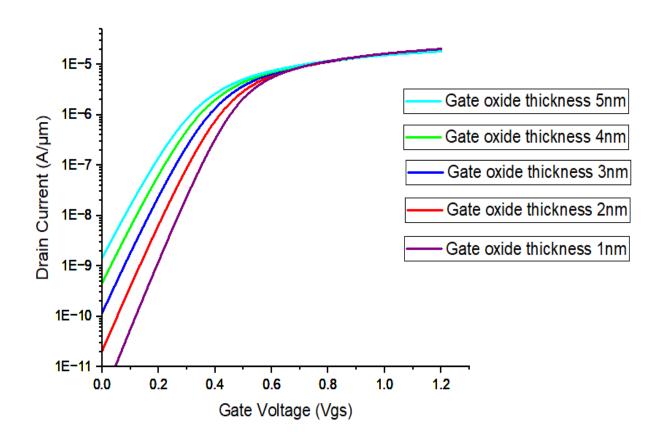
Dual Material Gate Junctionless FinFet

All variations are for first metal Titanium and second metal Aluminum.

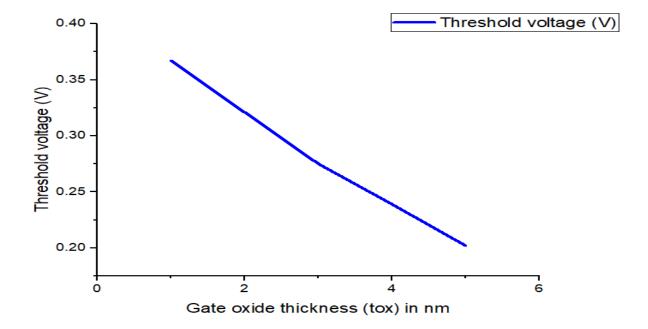
Variations in Gate oxide Thickness-



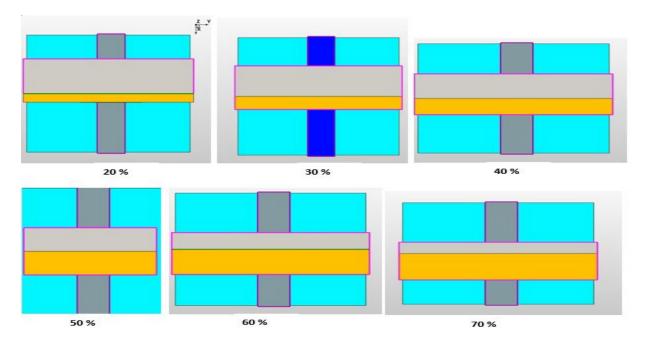
Plot-

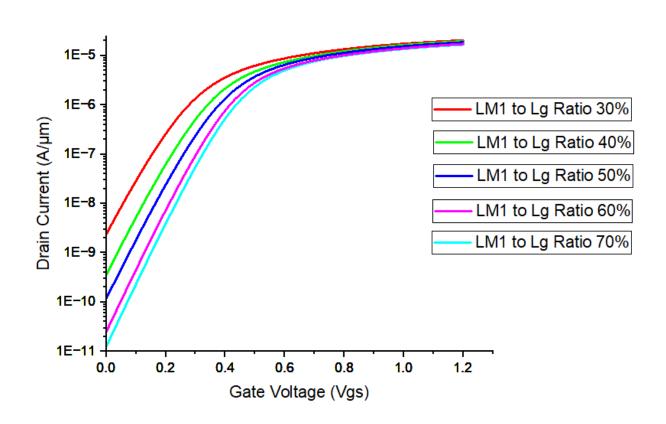


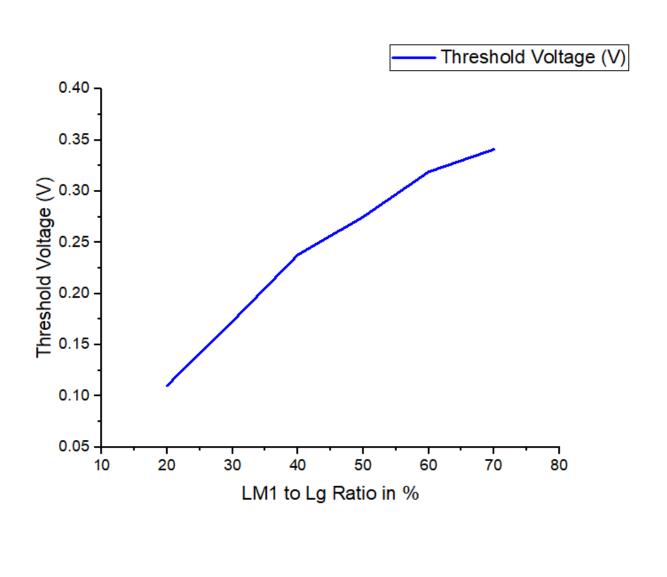
Threshold voltage vs Tox-



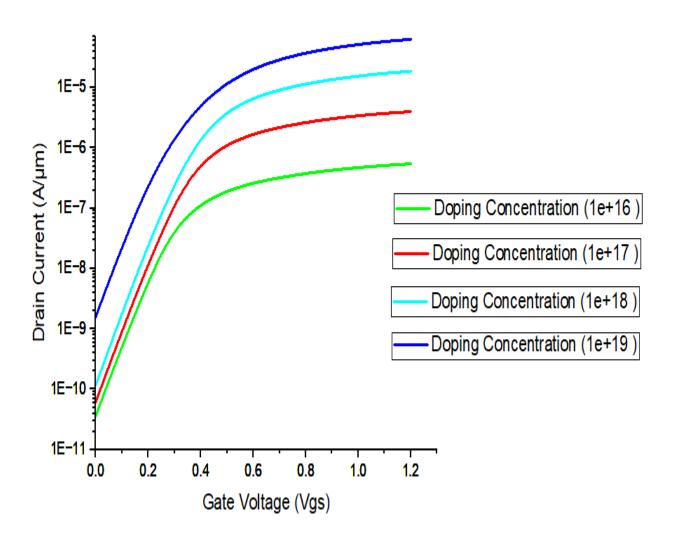
Ratio of Gate 1 to total gate length







Variation in concentration-



DIBL-

